Joint ICTP-IAEA School on Novel Experimental Methodologies for Synchrotron Radiation Applications in Nano-science and Environmental Monitoring | (smr 2611)

Contribution ID : 58

Type : not specified

Evaluation of XRF spectra: from basics to advanced systems

Thursday, 20 November 2014 14:30 (1:00)

Content

Summary

Presenter(s) :P. VAN ESPEN (University of Antwerpen - Belgium)Session Classification :not yet classified